# Advance Information

# **Power MOSFET**

# 25 V, 117 A, Single N-Channel, DPAK/IPAK

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

#### **Applications**

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltag	Drain-to-Source Voltage				
Gate-to-Source Voltag	е		$V_{GS}$	±20	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	19	Α
Current (R <sub>θJA</sub> ) (Note 1)		T <sub>A</sub> = 85°C		15	
Power Dissipation (R <sub>θJA</sub> ) (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.5	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	14.5	Α
Current (R <sub>θJA</sub> ) (Note 2)	Steady	T <sub>A</sub> = 85°C		11	
Power Dissipation (R <sub>0</sub> JA) (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.43	W
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	117	Α
Current (R <sub>θJC</sub> ) (Note 1)		T <sub>C</sub> = 85°C		91	
Power Dissipation $(R_{\theta JC})$ (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	93.75	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	230	Α
Current Limited by Pack	age	T <sub>A</sub> = 25°C	I <sub>DmaxPkg</sub>	45	Α
Operating Junction and	Storage Te	emperature	T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Source Current (Body D	Source Current (Body Diode)				
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain–to–Source Avalanche Energy ( $V_{DD}$ = 30 V, $V_{GS}$ = 10 V, L = 1.0 mH, $I_{L(pk)}$ = 30 A, $R_G$ = 25 $\Omega$ )			E <sub>AS</sub>	450	mJ
Lead Temperature for Sc (1/8" from case for 10 s)	ldering Pu	rposes	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

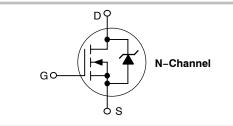
This document contains information on a new product. Specifications and information herein are subject to change without notice.



#### ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
25 V	4.0 mΩ @ 10 V	117 A	
25 V	5.5 mΩ @ 4.5 V	117 A	







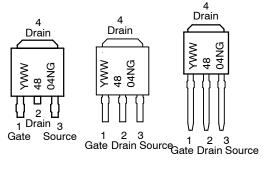


**DPAK** (Bend Lead) **CASE 369C** STYLE 2

(Straight Lead) (Straight Lead) CASE 369AD

**DPAK** CASE 369D STYLE 2

#### **MARKING DIAGRAMS** & PIN ASSIGNMENTS



= Year WW = Work Week 4804N = Device Code = Pb-Free Package

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter		Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.6	°C/W
Junction-to-TAB (Drain)	$R_{ heta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	60	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	105	

- Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				26		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μΑ
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)					•	•	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μΑ	1.5		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				7.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 to 11.5 V	I <sub>D</sub> = 30 A		3.4	4.0	mΩ
			I <sub>D</sub> = 15 A		3.4		1
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		4.7	5.5	
			I <sub>D</sub> = 15 A		4.6		
Forward Transconductance	gFS	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A			23		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>				4490		pF
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 12 \text{ V}$			952		
Reverse Transfer Capacitance	C <sub>rss</sub>				556		
Total Gate Charge	Q <sub>G(TOT)</sub>				30	40	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS}$ = 4.5 V, $V_{D}$	<sub>S</sub> = 15 V,		5.5		
Gate-to-Source Charge	$Q_{GS}$	I <sub>D</sub> = 30 .			13		
Gate-to-Drain Charge	$Q_{GD}$				13		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 11.5 V, V <sub>I</sub> I <sub>D</sub> = 30 A			73		nC
SWITCHING CHARACTERISTICS (Note	e 4)						
Turn-On Delay Time	t <sub>d(on)</sub>				28		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,			256		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 30 \text{ A, R}_G$			23		
Fall Time	t <sub>f</sub>		ľ		73		
Turn-On Delay Time	t <sub>d(on)</sub>				13		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 11.5 V, V <sub>[</sub>	<sub>OS</sub> = 15 V,		88		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 30 \text{ A}, R_G = 3.0 \Omega$			36		1

- Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
   Switching characteristics are independent of operating junction temperatures.

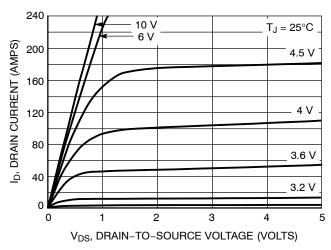
29

Fall Time

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERIS	TICS				•	•	•
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.81	1.2	V
		I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C		0.72		
Reverse Recovery Time	t <sub>RR</sub>		V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs,		34		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, dls}/$			19		
Discharge Time	tb	I <sub>S</sub> = 30 A			15		
Reverse Recovery Time	$Q_{RR}$				30		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				2.49		nΗ
Drain Inductance, DPAK	L <sub>D</sub>	1			0.0164		
Drain Inductance, IPAK	L <sub>D</sub>	$T_A = 3$	T <sub>A</sub> = 25°C		1.88		
Gate Inductance	L <sub>G</sub>				3.46		
Gate Resistance	R <sub>G</sub>	1			0.6		Ω

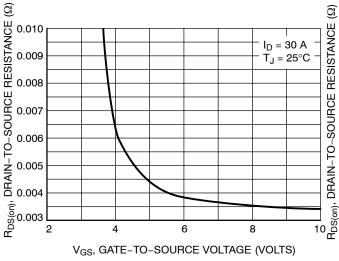
#### **TYPICAL PERFORMANCE CURVES**



240  $V_{DS} \ge 10 \text{ V}$ DRAIN CURRENT (AMPS) 200 160 120 80  $T_J = 125^{\circ}C$  $T_J = 25^{\circ}C$ Õ 40 T<sub>J</sub> = -55°C 0 5 6 7 0 2 3 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



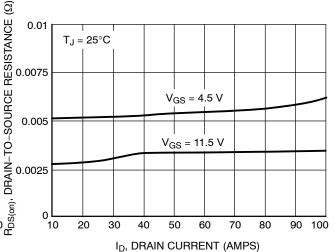
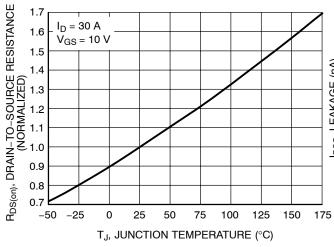


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



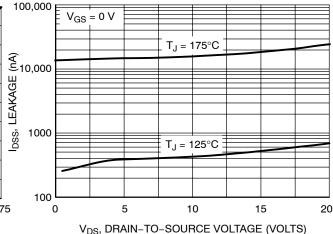
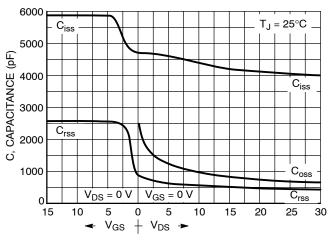


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

#### TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

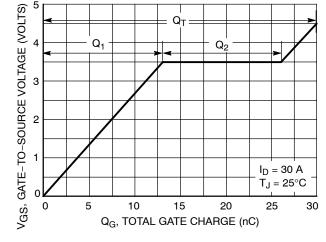


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



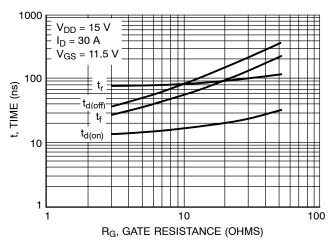


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

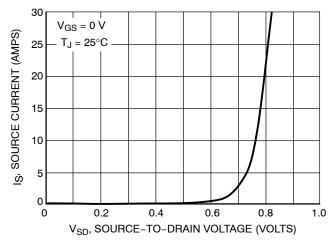


Figure 10. Diode Forward Voltage vs. Current

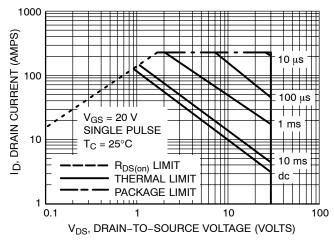


Figure 11. Maximum Rated Forward Biased Safe Operating Area

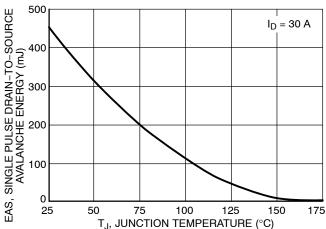


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

#### **TYPICAL PERFORMANCE CURVES**

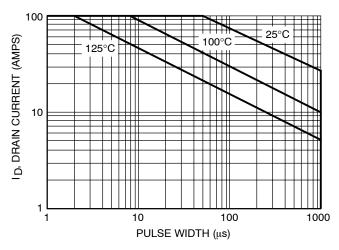


Figure 13. Avalanche Characteristics

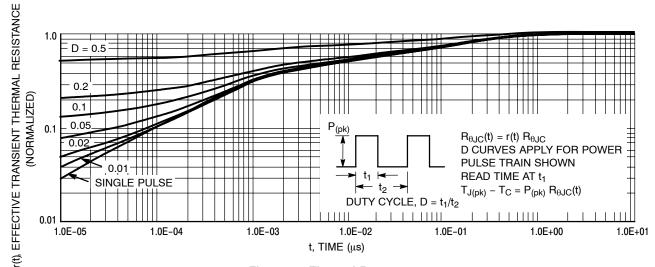


Figure 14. Thermal Response

### **ORDERING INFORMATION**

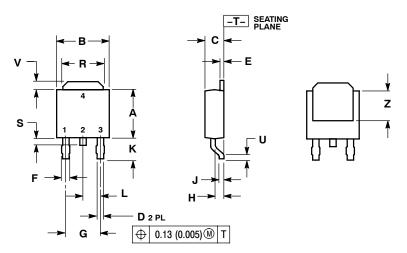
Order Number	Package	Shipping <sup>†</sup>
NTD4804NAT4G	DPAK (Pb-Free)	2500 Tape & Reel
NTD4804NA-1G	IPAK (Pb-Free)	75 Units/Rail
NTD4804NA-35G	IPAK Trimmed Lead (3.5 $\pm$ 0.15 mm) (Pb-Free)	75 Units/Rail

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **PACKAGE DIMENSIONS**

#### **DPAK**

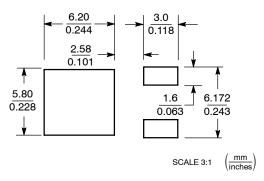
CASE 369C-01 ISSUE O



- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180	BSC	4.58 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29	BSC
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
Z	0 155		3.93	

#### **SOLDERING FOOTPRINT\***

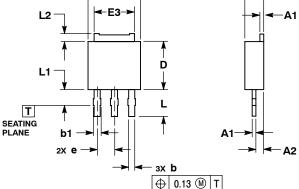


<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

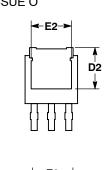
#### PACKAGE DIMENSIONS

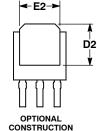
3.5 MM IPAK, STRAIGHT LEAD

# CASE 369AD-01 **ISSUE O** -E2→



E





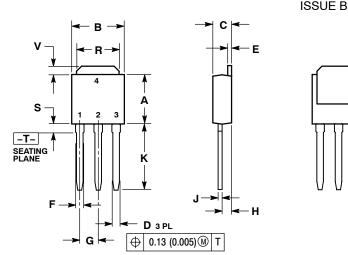
Z

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
   ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
   DIMENSION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND
- 0.30mm FROM TERMINAL TIP.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD GATE OR MOLD FLASH.

	MILLIMETERS				
DIM	MIN	MAX			
Α	2.19	2.38			
A1	0.46	0.60			
A2	0.87	1.10			
b	0.69	0.89			
b1	0.77	1.10			
D	5.97	6.22			
D2	4.80				
E	6.35	6.73			
E2	4.70				
E3	4.45	5.46			
е	2.28	BSC			
L	3.40	3.60			
L1		2.10			
L2	0.89	1.27			

#### **DPAK** CASE 369D-01



#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982
- CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
E	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	BSC	2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
V	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

#### STYLE 2:

PIN 1. GATE

- DRAIN 2.
- SOURCE DRAIN

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